

Segmenting Brain Tumors with Conditional Random Fields and Support Vector Machines

Chi-Hoon Lee¹, Mark Schmidt¹, Albert Murtha², Aalo Bistritz², Joerg Sander¹, and Russell Greiner¹

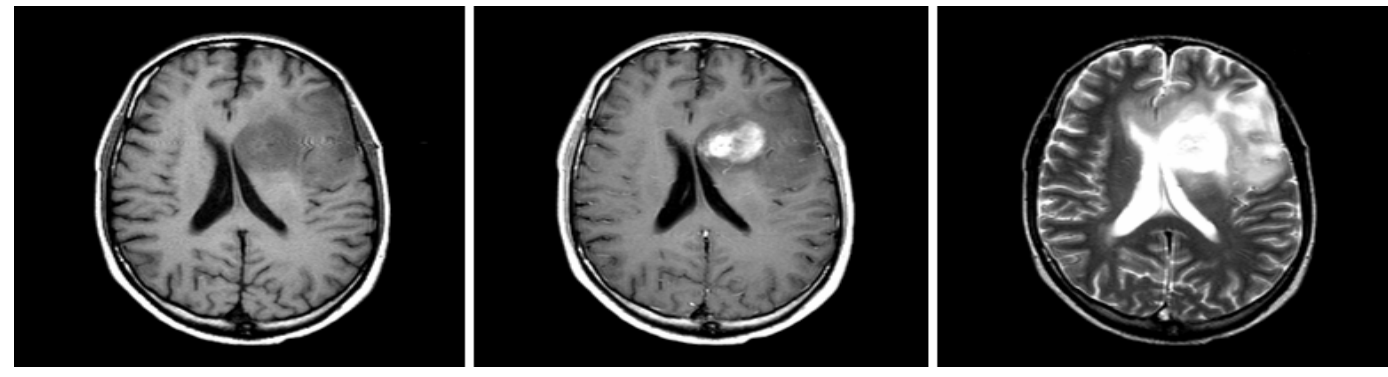
¹Dept. of Computing Science, The University of Alberta
²Dept. of Oncology, Cross Cancer Institute, Edmonton, AB, Canada

Introduction

Task:

Segmenting Brain Tumors in MR images

- Input: T1, T1c, T2 images



Left to right:
T1,
T1 with contrast agent,
T2 image

- Output:

- Edema, Enhancing and Gross Tumor areas



Left to right:
Edema,
Enhancing,
Gross Tumor areas

Motivation:

- Want accurate segmentation
- Considered using effective classifier – SVM
- But SVM assumes data is iid, but our imaging data is not
- adjacent voxels typically have same labels

Goal:

- Synthesize SVM-ideas into “Random Field” classifier

Background

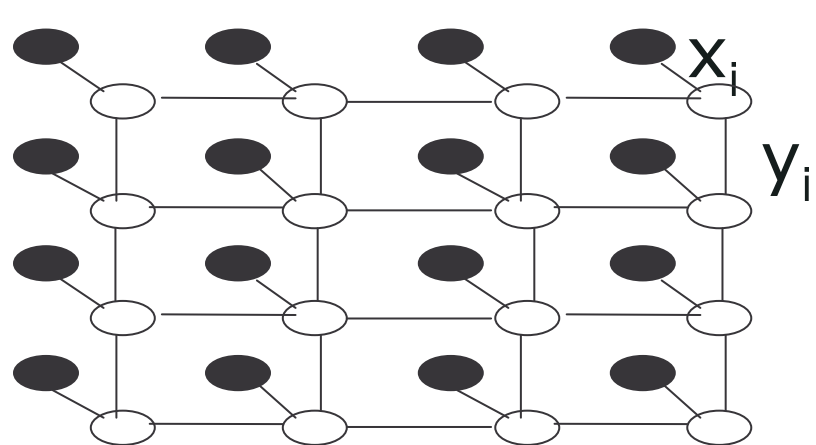
1a. Markov Random Field (MRF)

- Allows the label of one pixel to depend on the labels of neighboring pixels
- Generative** approach: computes $P(Y|X)$ using the Baye’s rule for features of set of pixels $X = \{x_1, \dots, x_n\}$ and labels $Y = \{y_1, \dots, y_n\}$

$$P(Y | X) \propto p(X | Y) p(Y) = \exp \left[\sum_{i=1}^n \log(p(y_i | x_i)) + \sum_{j \in N_i} V(y_i, y_j, X) \right]$$

General MRF model:

- N_i is neighboring pixels of i
- $V(y_i, y_j, X) \geq 0$ is arbitrary potential function having the same class label as neighbors
- $p(y_i | x_i)$ is modeled as Gaussian



- Shaded nodes are observed $\{x_i\}$
- Unshaded nodes are unobserved labels $\{y_i\}$
- Edges between nodes indicate dependencies

Issues:

- Must compute joint probability
- To be tractable, uses problematic independence assumption:
 $p(X | Y) = \prod_i p(x_i | y_i)$
- Cannot model complex dependencies between features and labels

1b. Discriminative Random Fields (DRF)

- Discriminative** (not generative)
- Directly model $P(Y|X)$ -- the posterior probability of labels given features

$$P(Y | X) \propto \exp \left\{ \sum_{i=1}^n A(y_i, X) + \sum_{j \in N_i} I(y_i, y_j, X) \right\}$$

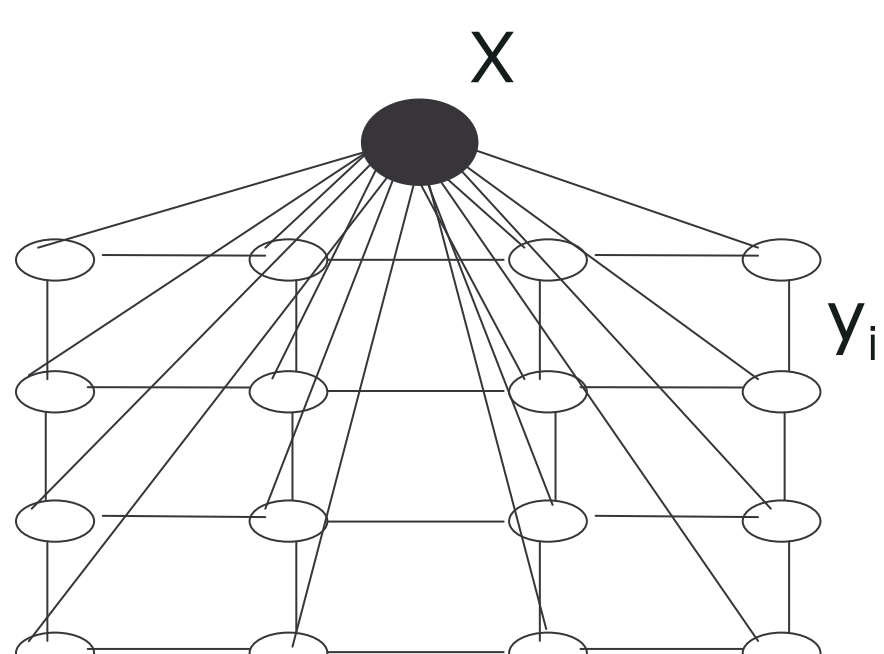
General CRF model:

- N_i is neighboring pixels of i
- $A(y_i, X)$ is “Association” (Observation-Matching) potential
- $I(y_i, y_j, X)$ is “Interaction” (Local consistency) potential

- Can use $A(y_i, X)$ to model complex dependencies between (features of) pixel and its label
- Can use $I(y_i, y_j, X)$ to model complex dependencies between (features of) neighboring pixels and their labels
 - In MRF: only model spatial correlation by only considering labels of adjacent pixels
- DRF uses
 - ✓ Logistic Regression for Observation Matching potential, $A(y_i, X)$
 - ✓ Linear function for the Local-Consistency potential, to model spatial dependencies: $I(y_i, y_j, X) = y_i y_j^T \phi(x_i, x_j)$
- Conditional Random Field (CRF) is a simple 1D version of a DRF

Issues:

- Simultaneously learning both $A(\cdot)$ and $I(\cdot)$
 - Possible inappropriate spatial dependencies modeling
- Correlated high dimensional data feature space
 - Inappropriate parameter estimation
- Non-trivial to find a good initial labeling for inference

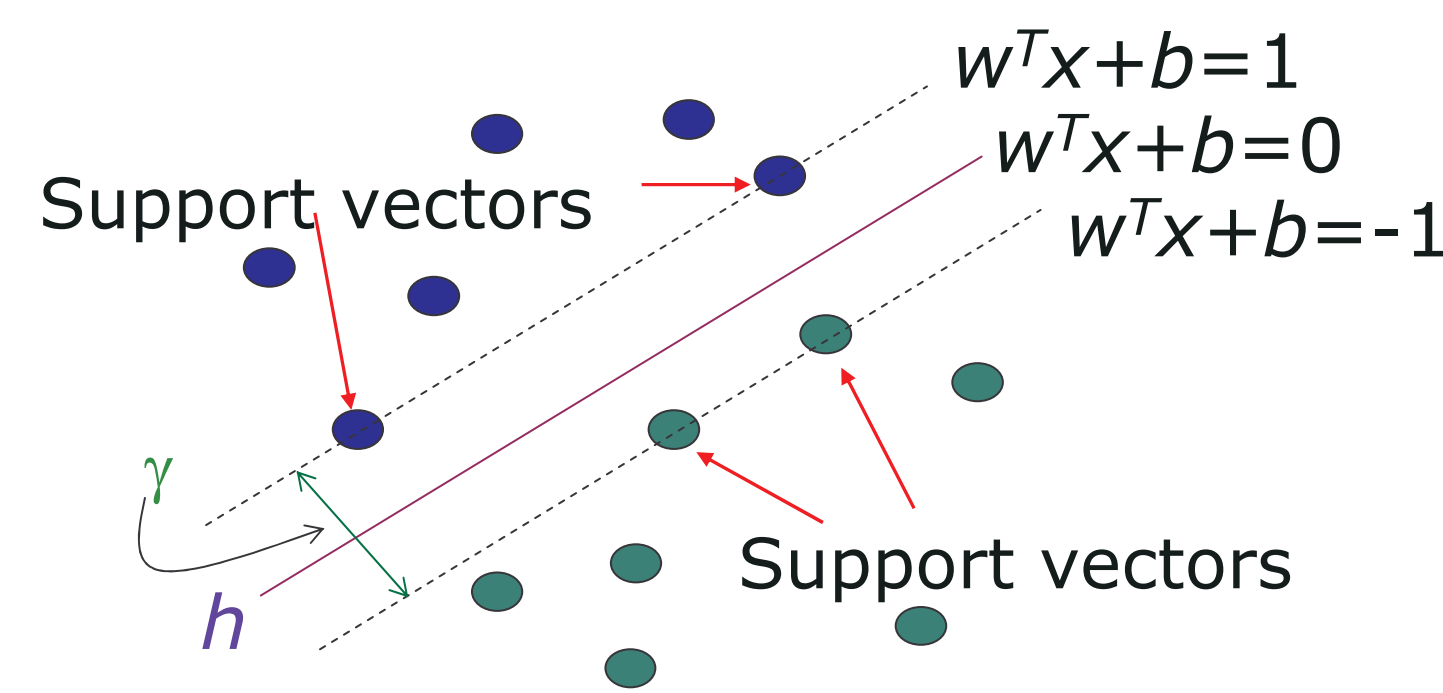


Challenges a DRF must address, which are solved by Support Vector Machines !

- Shaded nodes are observed $\{x_i\}$
- Unshaded nodes are unobserved labels $\{y_i\}$
- Edges between nodes indicate dependencies

2. Support Vector Machines (SVM)

- A popular tool for learning classifiers of iid data
- Creates a hyperplane h that separates the data into two classes
 - Maximizing the margin γ , where “margin” = distance from closest data object to the hyperplane
- Less sensitive to class imbalance than Logistic Regression
- Issues:
 - Use iid assumption
 - Spatial correlation not considered



Decision function: $f(x) = w^T x + b$
 $f(x)$ = distance from x to the hyperplane perpendicular to w
 Class label = $\text{sign}(f(x))$

SVRF (Support Vector Random Field)

- Extend DRF by basing $A(y_i, X)$ on SVM, not LR
- Less sensitive to unbalanced data than MRF and DRF
- More efficient learning method
 - address the disadvantage of DRF’s simultaneous parameter learning

$$P(Y | X) \propto \exp \left\{ \sum_{i=1}^n \log(O(y_i, x_i)) + \sum_{j \in N_i} V(y_i, y_j, X) \right\}$$

$O(y_i | x_i) = \frac{1}{1 + \exp(-K \times f(x_i) + B)}$, where K and B are estimated from training data

$V(y_i, y_j, X) = y_i y_j^T \psi(x_i, x_j)$

- A linear Local-Consistency potential using 8 adjacent pixels as the neighborhood system

Experiments for Brain Tumor Segmentation.

➤ Data Sets: 7 Patients

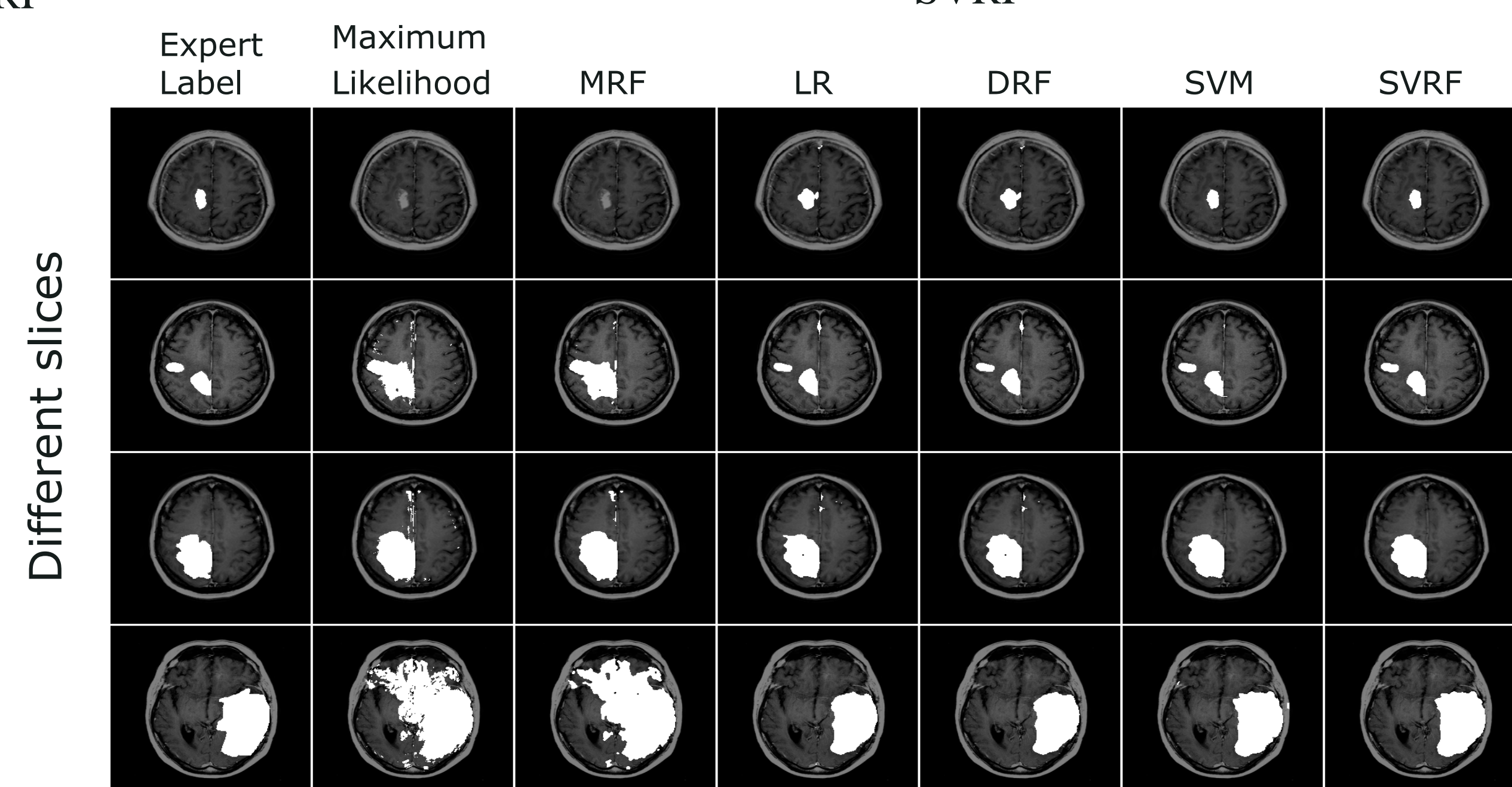
- Each with one of
 - grade 2 astrocytoma
 - anaplastic astrocytoma, or
 - glioblastoma multiforme
- Pre-processed to reduce noise, inter-slice variations, and intensity inhomogeneity with spatial registration

➤ Patient Specific Training and Testing

- For each patient #:
 - Train on data from slices 1 and 3 of patient #
 - Test on data from slices from 2 of patient #

➤ Systems considered:

- Maximum Likelihood classifier (degenerate MRF)
- SVM (degenerate SVRF)
- DRF
- Logistic Regression model (degenerate DRF)
- MRF
- SVRF



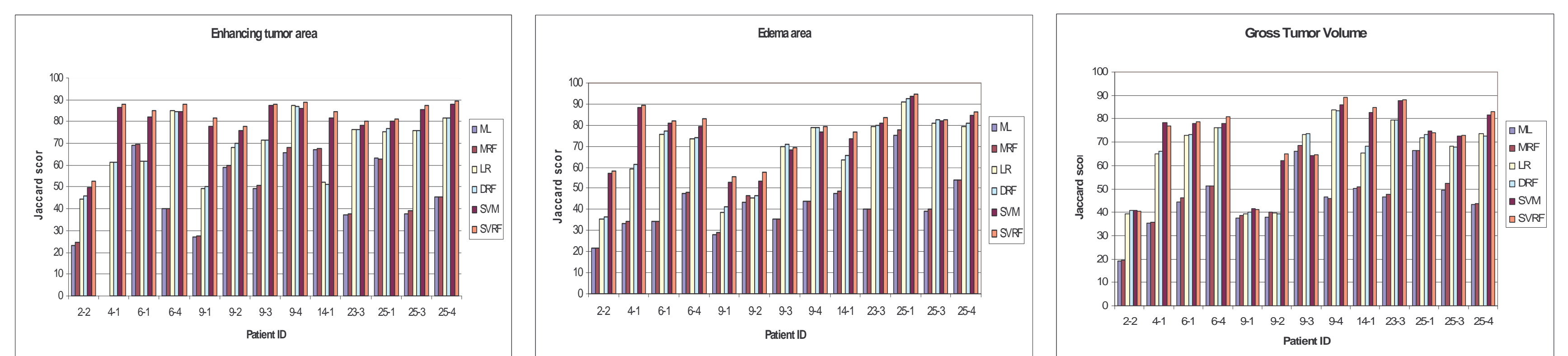
Classification results of enhancing tumor areas for 4 different test slices

➤ Evaluated by Jaccard score

- $J = TP / (TP + FP + FN)$
- true positive (TP), false positive (FP), false negative (FN)

➤ Results in summary

- Overall, $ML < MRF < LR < DRF < SVM < SVRF$
- Statistical significance (paired t-test)
 - SVRF is better than SVM at $p < 4.25E-11$



Jaccard score for 3 different tumor segmentation tasks: Left to right: Enhancing, Edema, and Gross Tumor areas

Conclusions

- Remaining issue for SVRF: Efficiency (learning, inference)
- Explored algorithms for segmenting brain tumor: both iid and with spatial correlations
- Standard Random Field algorithms often perform better than iid classifiers
- SVRF shows the best overall performance